


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509616	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAHASHI ET AL.
	<b>Examiner</b>  Alain L Bashore	<b>Art Unit</b>  1792

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
427	127, 128, 131, 132	3-27-08	ab

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (attached)	3-27-08	ab
Inventor and assignee search	3-27-08	ab
EAST (attached)	10-27-08	ab
previous search updated	10-27-08	ab

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Alain L Bashore/ Primary Examiner.Art Unit 1792
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